

**INFORMATION DISCLOSURE  
CITATION**

(Use several sheets if necessary)

PTO Form 1449

Attorney Docket No.

053848-5017

Application No.:

10/680,174

Applicants: Naoto INABA, *et al.*

Filing Date: October 8, 2003

Group Art Unit: 3662

U.S. PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Sub Class	Filing Date
JA	6,222,660	04/24/2001	Traa			
	5,966,678	10/12/1999	Lam			
	5,319,972	06/14/1994	Oblak, et al.			
	4,899,159	02/06/1990	Marchant			
	4,292,514	09/28/1981	Ohtomo			
	3,728,725	04/17/1973	Bauer			
	3,500,396	03/10/1970	Schmidt, et al.			
	3,386,091	05/23/1968	Muchlinski, et al.			
	3,364,482	01/16/1968	Sones			

**FOREIGN PATENT DOCUMENTS**

Document Number	Date	Country	Class	Sub Class	<u>Translation</u> YES NO	
GB 2 308 763	07/02/1997	United Kingdom				
WO 99/12052	03/11/1999	PCT				
WO 96/39611	12/12/1996	PCT				

Examiner



Date Considered

6/19/05

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Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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January 25, 2005

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## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>HA</i>	"Digital Image Processing Techniques Applied to the Radar Detection Problem", C.R. Guarino, Proceedings of Southeastcon. Williamsburg, Proceedings of the Southeast Conference, New York, IEEE, US, vol. 1, pp 702-706, April 7-10, 1991.
<i>HA</i>	"A Novel High-Gain Image Sensor Cell Based on Si p-n APD in Charge Storage Mode Operation", Komobuchi, et al., IEEE Transactions on Electron Devices, USA, vol. 37, no. 8, pp 1861-1868, August 1990.

Examiner

*LAH*

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*6/19/05*

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